

Search Notes**Application/Control No.**

10/770,074

Examiner

Toan M. Le

Applicant(s)/Patent under Reexamination

HAY, JENNIFER

Art Unit

2863

SEARCHED

Class	Subclass	Date	Examiner
702	179	5/27/2005	TL
702	189	5/27/2005	TL
73	78	5/31/2005	TL
73	85	5/31/2005	TL
73	81	5/31/2005	TL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Indenter, Hardness, Stress, Strain, Force	5/27/2005	TL
Indenter, Hardness, Setup, Point, Engagement, Profile, Deviation	5/31/2005	TL
Indenter, Multiple Standard Deviation	6/2/2005	TL
Indenter, Compensation, Standard Deviation	6/3/2005	TL
East, Web, and NPL search		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner